



Integrated  
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Systems, Inc.

**PRELIMINARY**

# ICS8432-01I

## 700MHz, CRYSTAL-TO-3.3V DIFFERENTIAL LVPECL FREQUENCY SYNTHESIZER

### GENERAL DESCRIPTION

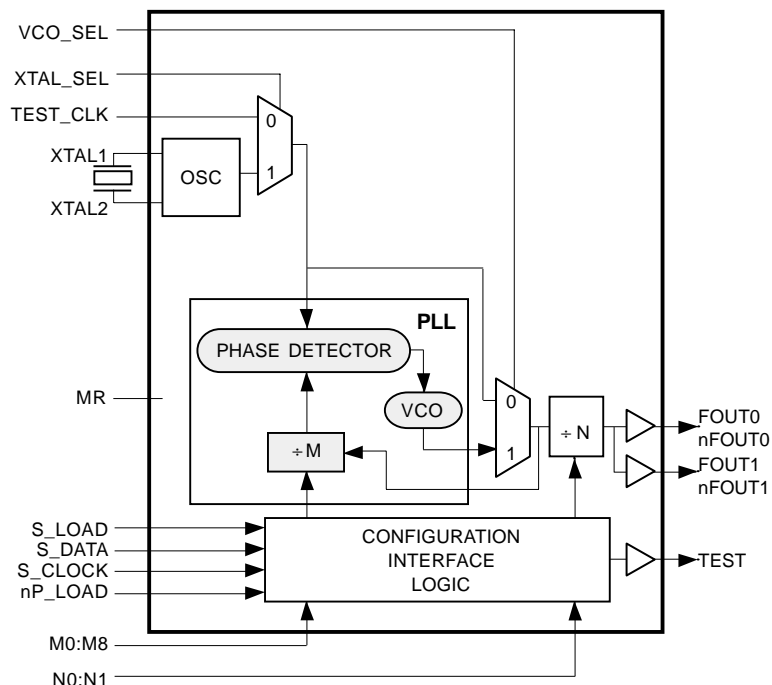


The ICS8432-01I is a general purpose, dual output Crystal-to-3.3V Differential LVPECL High Frequency Synthesizer and a member of the HiPerClockS™ family of High Performance Clock Solutions from ICS. The ICS8432-01I has a selectable TEST\_CLK or crystal inputs. The TEST\_CLK input accepts LVCMOS or LVTTTL input levels and translates them to 3.3V LVPECL levels. The VCO operates at a frequency range of 200MHz to 700MHz. The VCO frequency is programmed in steps equal to the value of the input reference or crystal frequency. The VCO and output frequency can be programmed using the serial or parallel interfaces to the configuration logic. The low phase noise characteristics of the ICS8432-01I make it an ideal clock source for Gigabit Ethernet, Fiber Channel 1 and 2, and Infiniband applications.

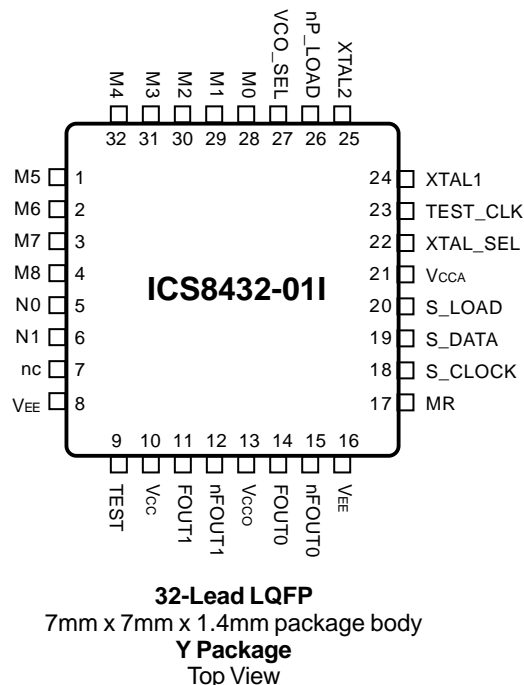
### FEATURES

- Dual differential 3.3V LVPECL output
- Selectable crystal oscillator interface or LVCMOS TEST\_CLK
- TEST\_CLK can accept the following input levels: LVCMOS or LVTTTL
- Maximum output frequency up to 700MHz
- Maximum crystal or TEST\_CLK input frequency up to 25MHz
- VCO range: 200MHz to 700MHz
- Parallel or serial interface for programming counter and output dividers
- RMS period jitter: TBDps (typical)
- Cycle-to-cycle jitter: 17ps (typical)
- 3.3V supply voltage
- -40°C to 85°C ambient operating temperature

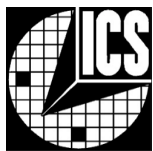
### BLOCK DIAGRAM



### PIN ASSIGNMENT



The Preliminary Information presented herein represents a product in prototyping or pre-production. The noted characteristics are based on initial product characterization. Integrated Circuit Systems, Incorporated (ICS) reserves the right to change any circuitry or specifications without notice.



#### FUNCTIONAL DESCRIPTION

**NOTE:** The functional description that follows describes operation using a 25MHz crystal. Valid PLL loop divider values for different crystal or input frequencies are defined in the Input Frequency Characteristics, Table 6, NOTE 1.

The ICS8432-01I features a fully integrated PLL and therefore requires no external components for setting the loop bandwidth. A fundamental crystal is used as the input to the on-chip oscillator. The output of the oscillator is fed into the phase detector. A 25MHz crystal provides a 25MHz phase detector reference frequency. The VCO of the PLL operates over a range of 200MHz to 700MHz. The output of the loop divider is also applied to the phase detector.

The phase detector and the loop filter divider force the VCO output frequency to be M times the reference frequency by adjusting the VCO control voltage. Note that for some values of M (either too high or too low) the PLL will not achieve lock. The output of the VCO is scaled by a divider prior to being sent to each of the LVPECL output buffers. The divider provides a 50% output duty cycle.

The programmable features of the ICS8432-01I support two input modes, programmable PLL loop divider and output divider. The two input operational modes are parallel and serial. Figure 1 shows the timing diagram for each mode. In parallel mode, the nP\_LOAD input is initially LOW. The data on inputs M0 through M8 and N0 and N1 is passed directly to the ripple counter. On the LOW-to-HIGH transition of the nP\_LOAD input, the data is latched and the ripple counter remains loaded until the next LOW transition on nP\_LOAD or until a serial event occurs. As a result, the M and N bits can be hardwired to set the ripple counter to a specific default state that will automatically occur during power-up. The TEST output is LOW when operating in the parallel input mode. The relationship between the VCO frequency, the crystal frequency and the loop divider is defined as follows:

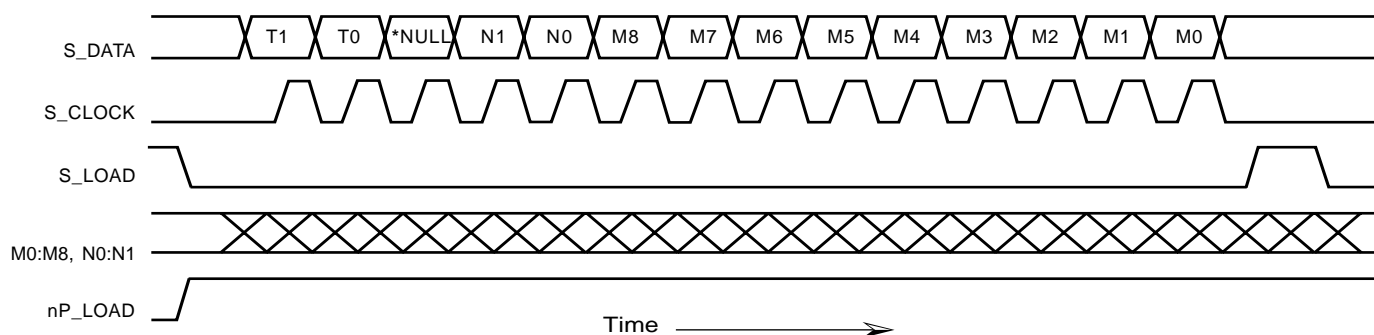
$$f_{VCO} = f_{xtal} \times M$$

The M count and the required values of M0 through M8 are shown in Table 4B, Programmable VCO Frequency Function. Valid M values for which the PLL will achieve lock for a 25MHz reference are defined as  $8 \leq M \leq 28$ . The frequency out is defined as follows:

$$F_{OUT} = \frac{f_{VCO}}{N} = f_{xtal} \times \frac{M}{N}$$

Serial operation occurs when nP\_LOAD is HIGH and S\_LOAD is LOW. The shift register is loaded by sampling the S\_DATA bits with the rising edge of S\_CLOCK. The contents of the shift register are loaded into the ripple counter when S\_LOAD transitions from LOW-to-HIGH. The ripple counter divide values are latched on the HIGH-to-LOW transition of S\_LOAD. If S\_LOAD is held HIGH, data at the S\_DATA input is passed directly to the ripple counter on each rising edge of S\_CLOCK. The serial mode can be used to program the M and N bits and test bits T1 and T0. The internal registers T0 and T1 determine the state of the TEST output as follows:

T1	T0	TEST Output
0	0	LOW
0	1	S_Data
1	0	Output of M divider
1	1	CMOS Fout



**FIGURE 1. PARALLEL & SERIAL LOAD OPERATIONS**

**\*NOTE:** The NULL timing slot must be observed.



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**TABLE 1. PIN DESCRIPTIONS**

Number	Name	Type		Description
1	M5	Input	Pullup	M counter/divider inputs. Data latched on LOW-to-HIGH transition of nP_LOAD input. LVCMOS / LVTTTL interface levels.
2, 3, 4, 28, 29, 30, 31, 32	M6, M7, M8, M0, M1, M2, M3, M4	Input	Pulldown	
5, 6	N0, N1	Input	Pulldown	
7	nc	Unused		No connect.
8, 16	V <sub>EE</sub>	Power		Negative supply pins. Connect to ground.
9	TEST	Output		Test output which is ACTIVE in the serial mode of operation. Output driven LOW in parallel mode. LVCMOS interface levels.
10	V <sub>CC</sub>	Power		Positive supply pin.
11, 12	FOUT1, nFOUT1	Output		Differential output for the synthesizer. 3.3V LVPECL interface levels.
13	V <sub>CCO</sub>	Power		Output supply pin. Connect to 3.3V.
14, 15	FOUT0, nFOUT0	Output		Differential output for the synthesizer. 3.3V LVPECL interface levels.
17	MR	Input	Pulldown	Forces outputs LOW, but does not effect loaded M, N, and T values. LVCMOS / LVTTTL interface levels.
18	S_CLOCK	Input	Pulldown	Clocks in serial data present at S_DATA input into the shift register on the rising edge of S_CLK.
19	S_DATA	Input	Pulldown	Shift register serial input. Data sampled on the rising edge of S_CLK.
20	S_LOAD	Input	Pulldown	Controls transition of data from shift register into the ripple counter. LVCMOS / LVTTTL interface levels.
21	V <sub>CCA</sub>	Power		Analog supply pin. Connect to 3.3V.
22	XTAL_SEL	Input	Pullup	Selects between crystal or test inputs as the PLL reference source. LVCMOS / LVTTTL interface levels. Selects XTAL inputs when HIGH. Selects TEST_CLK when LOW.
23	TEST_CLK	Input	Pulldown	Test clock input. LVCMOS / LVTTTL interface levels.
24, 25	XTAL1, XTAL2	Input		Crystal oscillator inputs.
26	nP_LOAD	Input	Pulldown	Parallel load input. Determines when data present at M8:M0 is loaded into ripple counter, and when data present at N1:N0 sets the output divide value. LVCMOS / LVTTTL interface levels.
27	VCO_SEL	Input	Pullup	Determines whether synthesizer is in PLL or bypass mode. LVCMOS / LVTTTL interface levels.

NOTE: *Pullup* and *Pulldown* refers to internal input resistors. See Table 2, Pin Characteristics, for typical values.

**TABLE 2. PIN CHARACTERISTICS**

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
C <sub>IN</sub>	Input Capacitance				4	pF
R <sub>PULLUP</sub>	Input Pullup Resistor			51		KΩ
R <sub>PULLDOWN</sub>	Input Pulldown Resistor			51		KΩ



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**TABLE 3A. PARALLEL AND SERIAL MODE FUNCTION TABLE**

Inputs							Conditions
MR	nP_LOAD	M	N	S_LOAD	S_CLOCK	S_DATA	
H	X	X	X	X	X	X	Reset. M and N counters reset.
L	L	Data	Data	X	X	X	Data on M and N inputs passed directly to the ripple counter and output divider. TEST output forced LOW.
L	↑	Data	Data	L	X	X	Data is latched into input registers and remains loaded until next LOW transition or until a serial event occurs.
L	H	X	X	L	↑	Data	Serial input mode. Shift register is loaded with data on S_DATA on each rising edge of S_CLOCK.
L	H	X	X	↑	L	Data	Contents of the shift register are passed to the ripple counter and output divider.
L	H	X	X	↓	L	Data	Ripple counter and output divide values are latched.
L	H	X	X	L	X	X	Parallel or serial input do not affect shift registers.
L	H	X	X	H	↑	Data	S_DATA passed directly to ripple counter as it is clocked.

NOTE: L = LOW  
H = HIGH  
X = Don't care  
↑ = Rising edge transition  
↓ = Falling edge transition

**TABLE 3B. PROGRAMMABLE VCO FREQUENCY FUNCTION TABLE**

VCO Frequency (MHz)	M Count	256	128	64	32	16	8	4	2	1
		M8	M7	M6	M5	M4	M3	M2	M1	M0
200	8	0	0	0	0	0	1	0	0	0
225	9	0	0	0	0	0	1	0	0	1
250	10	0	0	0	0	0	1	0	1	0
275	11	0	0	0	0	0	1	0	1	1
•	•	•	•	•	•	•	•	•	•	•
•	•	•	•	•	•	•	•	•	•	•
650	26	0	0	0	0	1	1	0	1	0
675	27	0	0	0	0	1	1	0	1	1
700	28	0	0	0	0	1	1	1	0	0

NOTE 1: These M count values and the resulting frequency correspond to crystal or test clock input frequency of 25MHz.

**TABLE 3C. PROGRAMMABLE OUTPUT DIVIDER FUNCTION TABLE**

Inputs		N Divider Value	Output Frequency (MHz)	
N1	N0		Minimum	Maximum
0	0	1	200	700
0	1	2	100	350
1	0	4	50	175
1	1	8	25	87.5



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### ABSOLUTE MAXIMUM RATINGS

Supply Voltage, $V_{CCx}$	4.6V
Inputs, $V_{CC}$	-0.5V to $V_{CC} + 0.5V$
Outputs, $V_{CCO}$	-0.5V to $V_{CCO} + 0.5V$
Package Thermal Impedance, $\theta_{JA}$	47.9°C/W (0 lfpm)
Storage Temperature, $T_{STG}$	-65°C to 150°C

Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed in the *DC Characteristics* or *AC Characteristics* is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

**TABLE 4A. POWER SUPPLY DC CHARACTERISTICS,  $V_{CC} = V_{CCA} = V_{CCO} = 3.3V \pm 5\%$ ,  $T_A = -40^\circ\text{C}$  TO  $85^\circ\text{C}$**

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
$V_{CC}$	Positive Supply Voltage		3.135	3.3	3.465	V
$V_{CCA}$	Analog Supply Voltage		3.135	3.3	3.465	V
$V_{CCO}$	Output Supply Voltage		3.135	3.3	3.465	V
$I_{EE}$	Power Supply Current				110	mA

**TABLE 4B. LVCMOS / LVTTTL DC CHARACTERISTICS,  $V_{CC} = V_{CCA} = V_{CCO} = 3.3V \pm 5\%$ ,  $T_A = -40^\circ\text{C}$  TO  $85^\circ\text{C}$**

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
$V_{IH}$	Input High Voltage	All input pins, except for XTAL1 and XTAL2	2		$V_{CC} + 0.3$	V
$V_{IL}$	Input Low Voltage	All input pins, except for XTAL1 and XTAL2	-0.3		0.8	V
$I_{IH}$	Input High Current	M0-M4, M6-M8, N0, N1, MR, S_CLOCK, TEST_CLK, S_DATA, S_LOAD, nP_LOAD	$*V_{CCx} = V_{IN} = 3.465V$		150	$\mu\text{A}$
		M5, XTAL_SEL, VCO_SEL	$V_{CCx} = V_{IN} = 3.465V$		5	$\mu\text{A}$
$I_{IL}$	Input Low Current	M0-M4, M6-M8, N0, N1, MR, S_CLOCK, TEST_CLK, S_DATA, S_LOAD, nP_LOAD	$V_{CCx} = 3.465V$ , $V_{IN} = 0V$	-5		$\mu\text{A}$
		M5, XTAL_SEL, VCO_SEL	$V_{CCx} = 3.465V$ , $V_{IN} = 0V$	-150		$\mu\text{A}$
$V_{OH}$	Output High Voltage	TEST	$V_{CCx} = 3.135V$ , $I_{OH} = -36mA$	2.6		V
$V_{OL}$	Output Low Voltage	TEST	$V_{CCx} = 3.135V$ , $I_{OL} = 36mA$		0.5	V

**\*NOTE 1:**  $V_{CCx}$  denotes  $V_{CC}$ ,  $V_{CCA}$ , and  $V_{CCO}$ .



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**TABLE 4C. LVPECL DC CHARACTERISTICS,  $V_{CC} = V_{CCA} = V_{CCO} = 3.3V \pm 5\%$ ,  $T_A = -40^\circ\text{C}$  TO  $85^\circ\text{C}$**

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
$V_{OH}$	Output High Voltage; NOTE 1		$V_{CCO} - 2.1$		$V_{CCO} - 1.0$	V
$V_{OL}$	Output Low Voltage; NOTE 1		$V_{CCO} - 2.0$		$V_{CCO} - 1.6$	V
$V_{SWING}$	Peak-to-Peak Output Voltage Swing		0.6		0.85	V

NOTE 1: Outputs terminated with  $50\ \Omega$  to  $V_{CCO} - 2V$ .

**TABLE 5. INPUT FREQUENCY CHARACTERISTICS,  $V_{CC} = V_{CCA} = V_{CCO} = 3.3V \pm 5\%$ ,  $T_A = -40^\circ\text{C}$  TO  $85^\circ\text{C}$**

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
$f_{IN}$	Input Frequency	TEST_CLK; NOTE 1	12		25	MHz
		XTAL1, XTAL2; NOTE 1	12		25	MHz
		S_CLOCK			50	MHz

NOTE 1: For the input crystal and TEST\_CLK frequency range, the M value must be set for the VCO to operate within the 200MHz to 700MHz range. Using the minimum input frequency of 12MHz, valid values of M are  $17 \leq M \leq 58$ . Using the maximum frequency of 25MHz, valid values of M are  $8 \leq M \leq 28$ .

**TABLE 6. CRYSTAL CHARACTERISTICS**

Parameter	Test Conditions	Minimum	Typical	Maximum	Units
Mode of Oscillation		Fundamental			
Frequency		12		25	MHz
Equivalent Series Resistance (ESR)		50		80	$\Omega$
Shunt Capacitance				7	pF
Series Pin Inductance		3		7	nH
Operating Temperature Range		0		70	$^\circ\text{C}$

**TABLE 7. AC CHARACTERISTICS,  $V_{CC} = V_{CCA} = V_{CCO} = 3.3V \pm 5\%$ ,  $T_A = -40^\circ\text{C}$  TO  $85^\circ\text{C}$**

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
$F_{OUT}$	Output Frequency		25		700	MHz
$f_{jit(cc)}$	Cycle-to-Cycle Jitter, RMS; NOTE 1, 3			17		ps
$f_{jit(per)}$	Period Jitter, RMS; NOTE 1, 3				TBD	ps
$t_{sk(o)}$	Output Skew; NOTE 2, 3				10	ps
$t_R$	Output Rise Time	20% to 80% @ 50MHz	300		700	ps
$t_F$	Output Fall Time	20% to 80% @ 50MHz	300		700	ps
$t_S$	Setup Time	M, N to nP_LOAD			5	ns
		S_DATA to S_CLOCK			5	ns
		S_CLOCK to S_LOAD			5	ns
$t_H$	Hold Time	M, N to nP_LOAD			5	ns
		S_DATA to S_CLOCK			5	ns
		S_CLOCK to S_LOAD			5	ns
odc	Output Duty Cycle		47		53	%
$t_{LOCK}$	PLL Lock Time				10	ms

All parameters measured at 500MHz unless noted otherwise.

NOTE 1: Jitter performance using Xtal inputs.

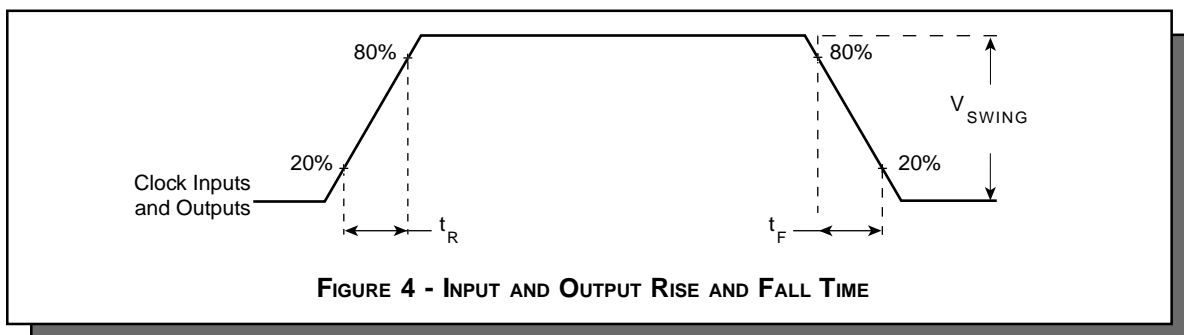
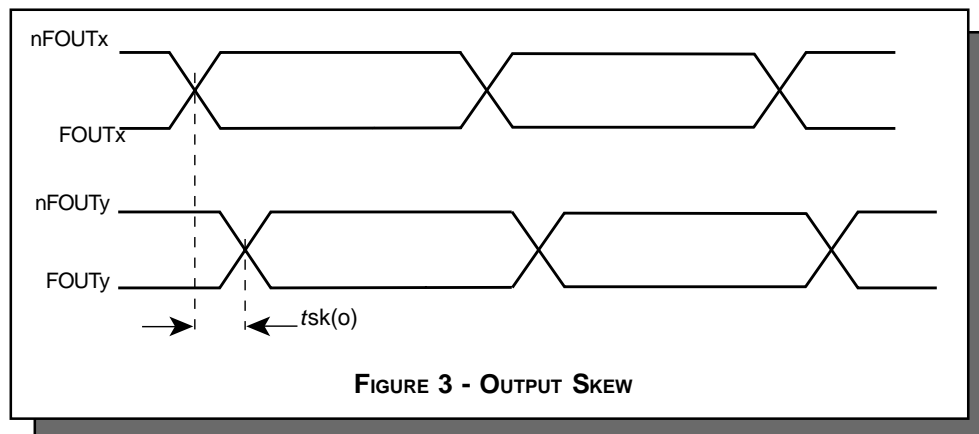
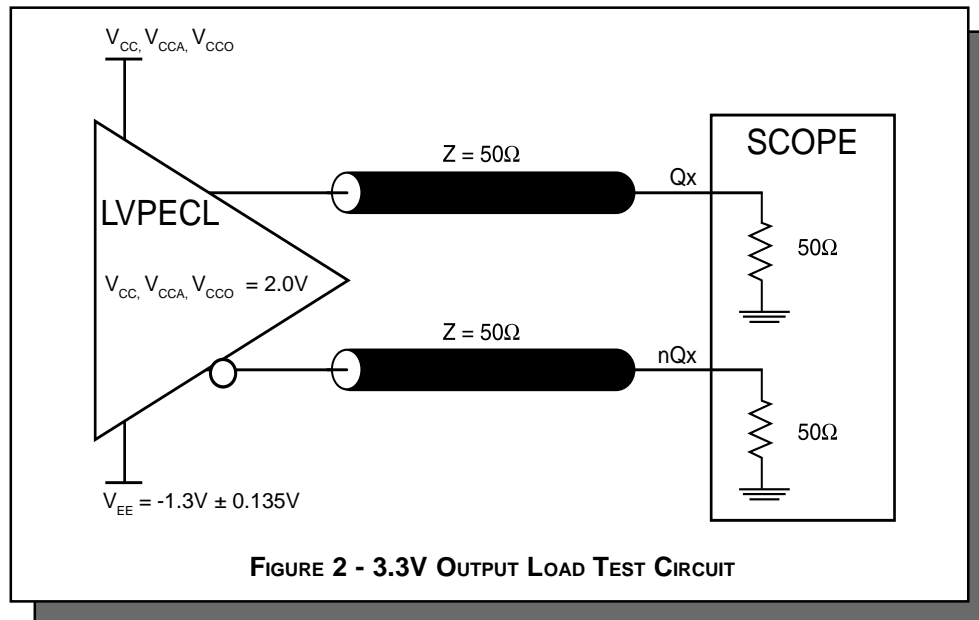
NOTE 2: Defined as skew between outputs at the same supply voltage and with equal load conditions.

Measured at the output differential cross points.

NOTE 3: This parameter is defined in accordance with JEDEC Standard 65.



## PARAMETER MEASUREMENT INFORMATION



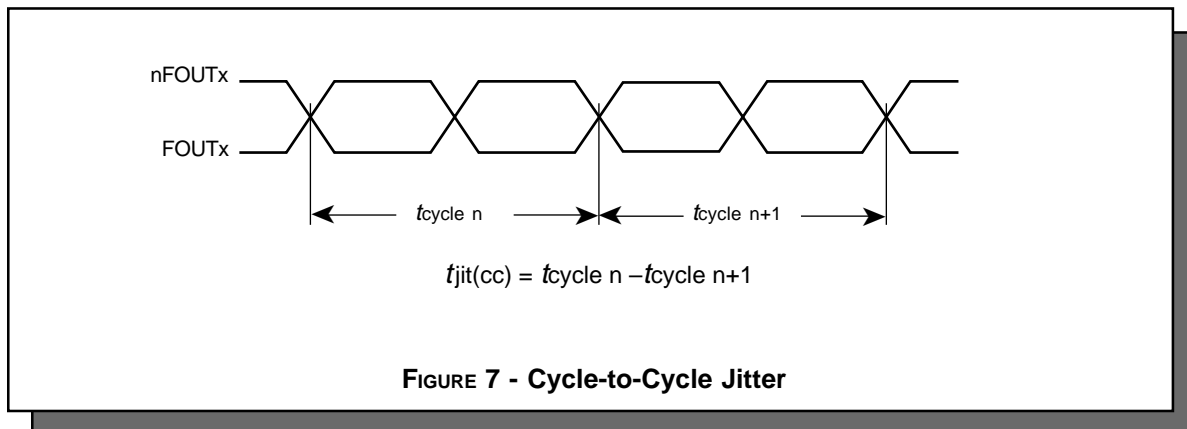
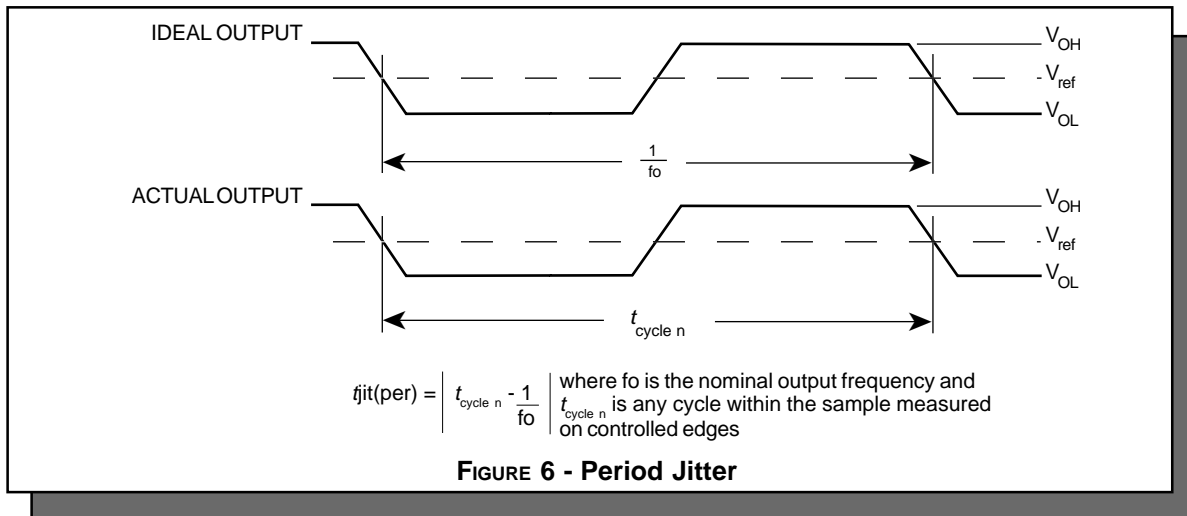
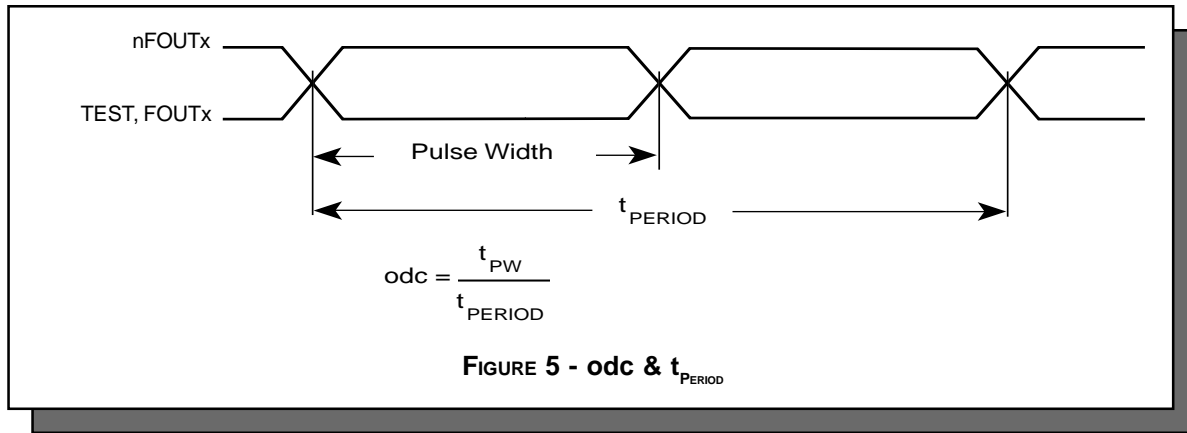


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## APPLICATIONS

### STORAGE AREA NETWORKS

A variety of technologies are used for interconnection of the elements within a SAN. The tables below list the common application frequencies as well as the ICS8432-01I configurations used to generate the appropriate frequency.

**Table 8. Common SANs Applications Frequencies**

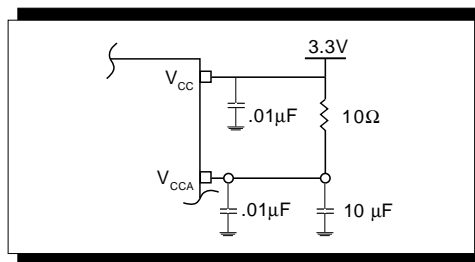
Interconnect Technology	Clock Rate	Reference Freq. to SERDES (MHz)	Crystal Frequency (MHz)
Gigabit Ethernet	1.25 GHz	125, 250, 156.25	25, 25, 19.53
Fibre Channel	FC1 1.0625 GHz FC2 2.1250 GHz	106.25, 53.125, 132.81	16.6, 25, 26.563
Infiniband	2.5 GHz	125, 250	25, 25

**Table 9. Configuration Details for SANs Applications**

Interconnect Technology	Crystal Frequency (MHz)	ICS8432-01I Output Frequency to SERDES (MHz)	ICS8432-01I M & N Settings											
			M8	M7	M6	M5	M4	M3	M2	M1	M0	N1	N0	
Gigabit Ethernet	25	125	0	0	0	0	0	1	0	1	0	1	0	
	25	250	0	0	0	0	0	1	0	1	0	0	0	
	19.53	156.25	0	0	0	0	1	0	0	0	0	1	0	
Fiber Channel 1	25	53.125	0	0	0	0	1	0	0	0	1	1	1	
	25	106.25	0	0	0	0	1	0	0	0	1	1	0	
Fiber Channel 2	16.6	132.81	0	0	0	0	1	0	0	0	0	0	1	
Infiniband	25	125	0	0	0	0	0	1	0	1	0	0	1	
	25	250	0	0	0	0	0	1	0	1	0	0	0	

## POWER SUPPLY FILTERING TECHNIQUES

As in any high speed analog circuitry, the power supply pins are vulnerable to random noise. The ICS8432-01 provides separate power supplies to isolate any high switching noise from the outputs to the internal PLL.  $V_{CC}$ ,  $V_{CCA}$ , and  $V_{CCO}$  should be individually connected to the power supply plane through vias, and bypass capacitors should be used for each pin. To achieve optimum jitter performance, power supply isolation is required. Figure 8 illustrates how a 10Ω resistor along with a 10μF and a .01μF bypass capacitor should be connected to each power supply pin.



**FIGURE 8. POWER SUPPLY FILTERING**



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### CRYSTAL INPUT AND OSCILLATOR INTERFACE

The ICS8432-01I features an internal oscillator that uses an external quartz crystal as the source of its reference frequency. The oscillator is a series resonant, multi-vibrator type design. This design provides better stability and eliminates the need for large on chip capacitors. Though a series resonant crystal is preferred, a parallel resonant crystal can be used. A parallel resonant mode crystal used in a series resonant circuit will exhibit a frequency of oscillation a few hundred ppm lower than specified. A few hundred ppm translates to KHz inaccuracy. In general computing applications, this level of inaccuracy is irrelevant. If better ppm accuracy is required, an external capacitor can be added to a parallel resonant crystal in series to pin 25. *Figure 9A* shows how to interface with a crystal.

Figures 9A, 9B, and 9C show various crystal parameters which are recommended only as guidelines. *Figure 9A* shows how to interface a capacitor with a parallel resonant crystal. *Figure 9B* shows the capacitor value needed for the optimum PPM performance over various parallel resonant crystal frequencies. *Figure 9C* shows the recommended tuning capacitance for various parallel resonant crystals.

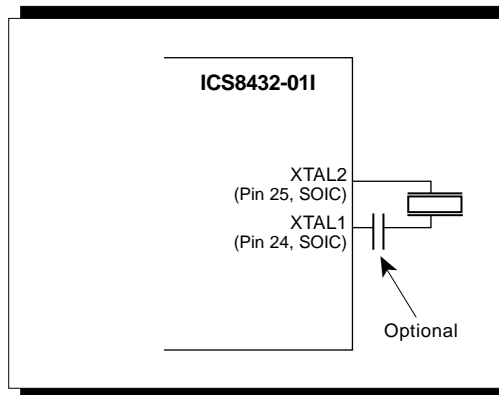


FIGURE 9A. CRYSTAL INTERFACE

FIGURE 9B. Recommended tuning capacitance for various parallel resonant crystals.

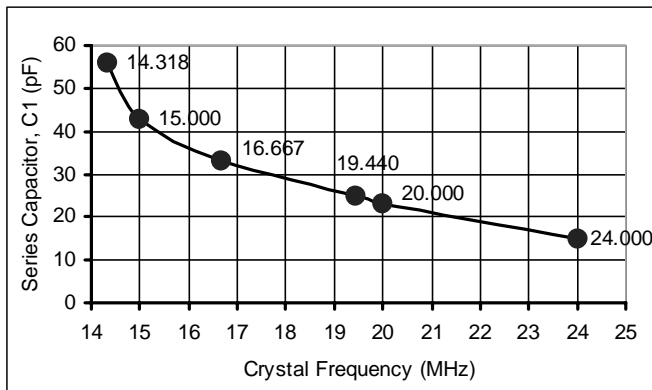
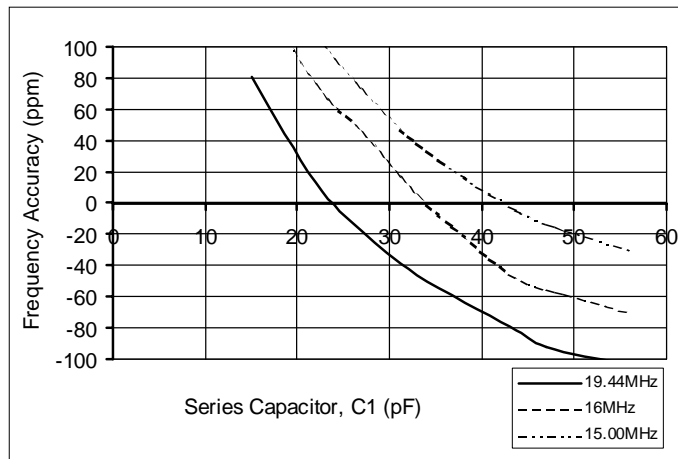


FIGURE 9C. Recommended tuning capacitance for various parallel resonant crystals.

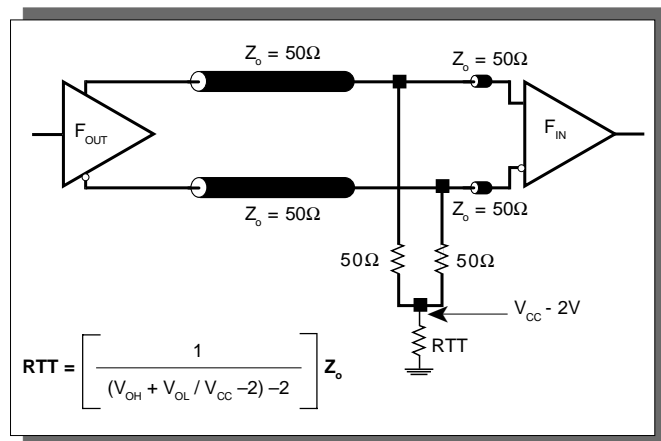


## TERMINATION FOR LVPECL OUTPUTS

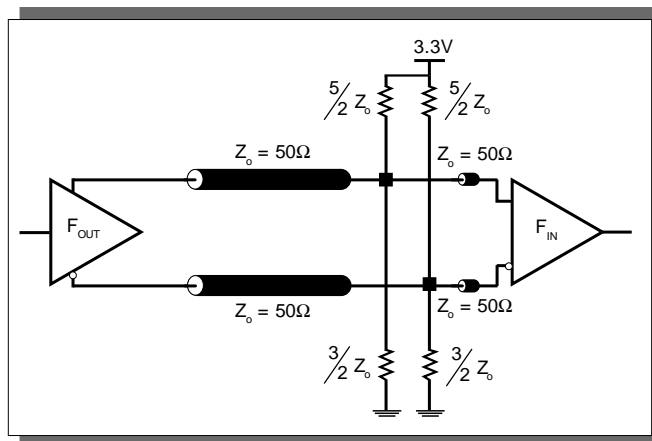
The clock layout topology shown below is a typical termination for LVPECL outputs. The two different layouts mentioned are recommended only as guidelines.

FOUT and nFOUT are low impedance follower outputs that generate ECL/LVPECL compatible outputs. Therefore, terminating resistors (DC current path to ground) or current sources must be used for functionality. These outputs are designed to

drive 50Ω transmission lines. Matched impedance techniques should be used to maximize operating frequency and minimize signal distortion. There are a few simple termination schemes. *Figures 10A and 10B* show two different layouts which are recommended only as guidelines. Other suitable clock layouts may exist and it would be recommended that the board designers simulate to guarantee compatibility across all printed circuit and clock component process variations.



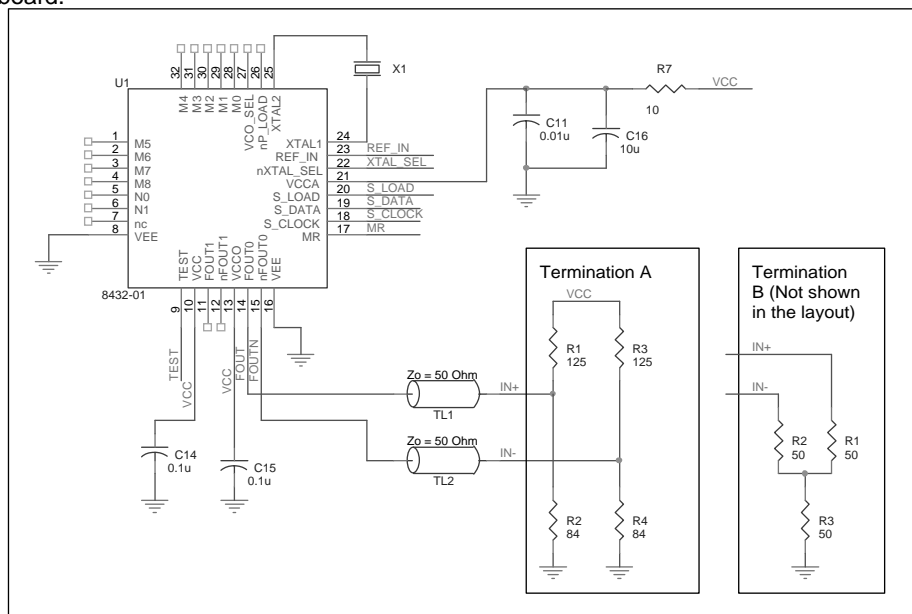
### FIGURE 10A. LVPECL OUTPUT TERMINATION



### FIGURE 10B. LVPECL OUTPUT TERMINATION

## LAYOUT GUIDELINE

The schematic of the ICS8432-011 layout example used in this layout guideline is shown in *Figure 11A*. The ICS8432-011 recommended PCB board layout for this example is shown in *Figure 11B*. This layout example is used as a general guideline. The layout in the actual system will depend on the selected component types, the density of the components, the density of the traces, and the stacking of the P.C. board.



### FIGURE 11A. RECOMMENDED SCHEMATIC LAYOUT



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**PRELIMINARY**

# ICS8432-01I

## 700MHz, CRYSTAL-TO-3.3V DIFFERENTIAL LVPECL FREQUENCY SYNTHESIZER

The following component footprints are used in this layout example: All the resistors and capacitors are size 0603.

### POWER AND GROUNDING

Place the decoupling capacitors C14 and C15 as close as possible to the power pins. If space allows, placing the decoupling capacitor at the component side is preferred. This can reduce unwanted inductance between the decoupling capacitor and the power pin generated by the via.

Maximize the pad size of the power (ground) at the decoupling capacitor. Maximize the number of vias between power (ground) and the pads. This can reduce the inductance between the power (ground) plane and the component power (ground) pins.

If  $V_{CCA}$  shares the same power supply with  $V_{CC}$ , insert the RC filter R7, C11, and C16 in between. Place this RC filter as close to the  $V_{CCA}$  as possible.

### CLOCK TRACES AND TERMINATION

The component placements, locations and orientations should be arranged to achieve the best clock signal quality. Poor clock signal quality can degrade the system performance or cause system failure. In the synchronous high-speed digital system, the clock signal is less tolerable to poor signal quality than other signals. Any ringing on the rising or falling edge or excessive ring back can cause system failure. The trace shape and the trace delay might be restricted by the available space on the board and the component location. While routing the traces, the clock signal traces should be

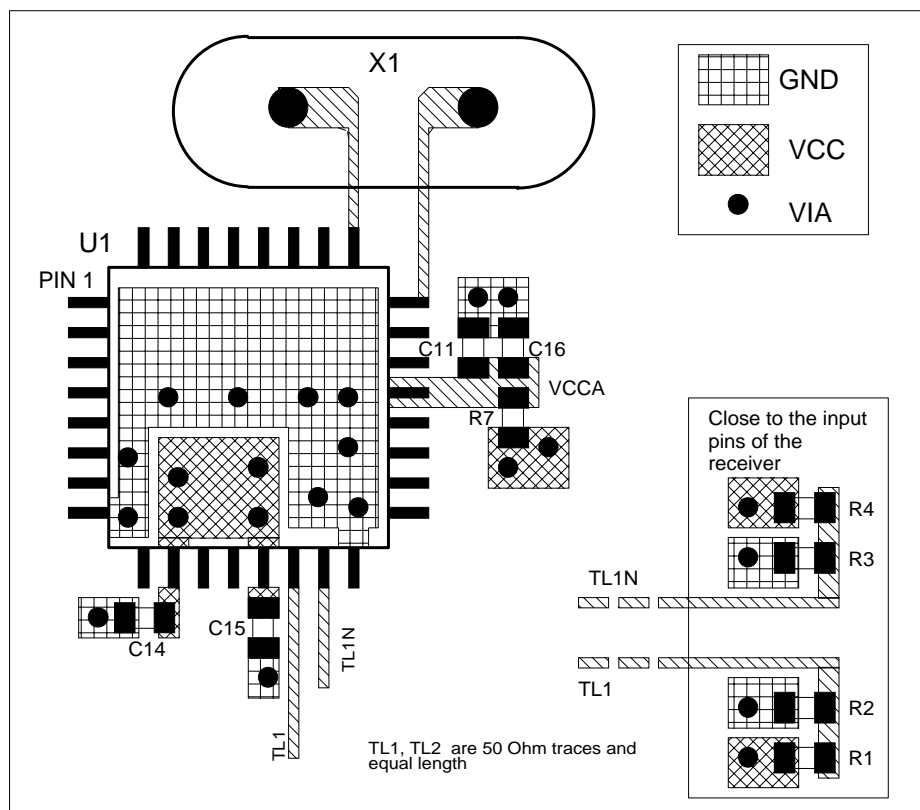
routed first and should be locked prior to routing other signal traces.

- The traces with 50Ω transmission lines TL1 and TL2 at FOUT and nFOUT should have equal delay and run adjacent to each other. Avoid sharp angles on the clock trace. Sharp angle turns cause the characteristic impedance to change on the transmission lines.
- Keep the clock trace on same layer. Whenever possible, avoid any vias on the clock traces. Any via on the trace can affect the trace characteristic impedance and hence degrade signal quality.
- To prevent cross talk, avoid routing other signal traces in parallel with the clock traces. If running parallel traces is unavoidable, allow more space between the clock trace and the other signal trace.
- Make sure no other signal trace is routed between the clock trace pair.

The matching termination resistors R1, R2, R3 and R4 should be located as close to the receiver input pins as possible. Other termination schemes can also be used but are not shown in this example.

### CRYSTAL

The crystal X1 should be located as close as possible to the pins 24 (XTAL1) and 25 (XTAL2). The trace length between the X1 and U1 should be kept to a minimum to avoid unwanted parasitic inductance and capacitance. Other signal traces should not be routed near the crystal traces.



**FIGURE 11B. PCB BOARD LAYOUT FOR ICS8432-01I**



## POWER CONSIDERATIONS

This section provides information on power dissipation and junction temperature for the ICS8432-01I. Equations and example calculations are also provided.

### 1. Power Dissipation.

The total power dissipation for the ICS8432-01I is the sum of the core power plus the power dissipated in the load(s). The following is the power dissipation for  $V_{CC} = 3.3V + 5\% = 3.465V$ , which gives worst case results.

**NOTE:** Please refer to Section 3 for details on calculating power dissipated in the load.

- Power (core)<sub>MAX</sub> =  $V_{CC\_MAX} * I_{EE\_MAX} = 3.465V * 110mA = 381.2mW$
- Power (outputs)<sub>MAX</sub> = **30.2mW/Loaded Output pair**  
If all outputs are loaded, the total power is  $2 * 30.2mW = 60.4mW$

$$\text{Total Power}_{MAX} (3.465V, \text{ with all outputs switching}) = 381.2mW + 60.4mW = 441.6mW$$

### 2. Junction Temperature.

Junction temperature,  $T_j$ , is the temperature at the junction of the bond wire and bond pad and directly affects the reliability of the device. The maximum recommended junction temperature for HiPerClockS™ devices is 125°C.

The equation for  $T_j$  is as follows:  $T_j = \theta_{JA} * Pd\_total + T_A$

$T_j$  = Junction Temperature

$\theta_{JA}$  = junction-to-ambient thermal resistance

$Pd\_total$  = Total device power dissipation (example calculation is in section 1 above)

$T_A$  = Ambient Temperature

In order to calculate junction temperature, the appropriate junction-to-ambient thermal resistance  $\theta_{JA}$  must be used. Assuming a moderate air flow of 200 linear feet per minute and a multi-layer board, the appropriate value is 42.1°C/W per Table 10 below.

Therefore,  $T_j$  for an ambient temperature of 70°C with all outputs switching is:  
 $70^\circ C + 0.441W * 42.1^\circ C/W = 88.6^\circ C$ . This is well below the limit of 125°C

This calculation is only an example.  $T_j$  will obviously vary depending on the number of loaded outputs, supply voltage, air flow, and the type of board (single layer or multi-layer).

**Table 10. Thermal Resistance  $\theta_{JA}$  for 32-pin LQFP, Forced Convection**

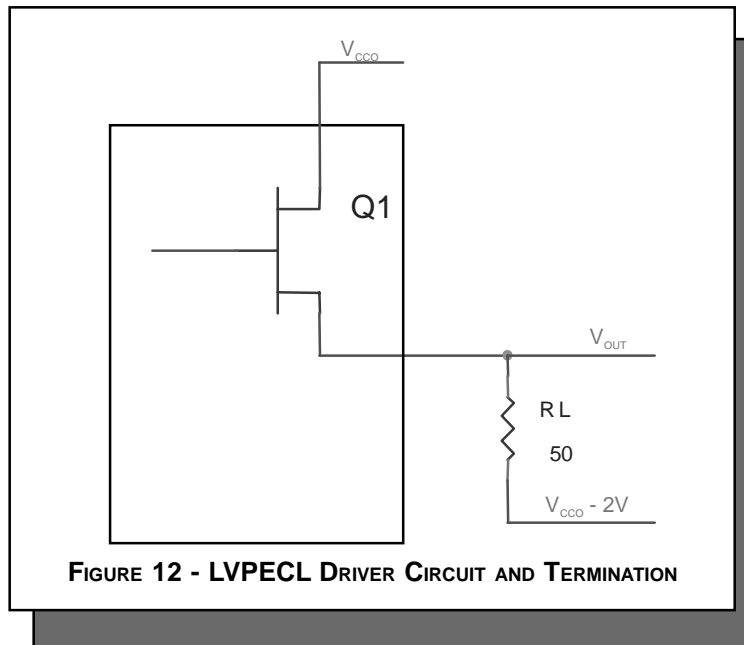
$\theta_{JA}$ by Velocity (Linear Feet per Minute)			
	0	200	500
Single-Layer PCB, JEDEC Standard Test Boards	67.8°C/W	55.9°C/W	50.1°C/W
Multi-Layer PCB, JEDEC Standard Test Boards	47.9°C/W	42.1°C/W	39.4°C/W
<b>NOTE:</b> Most modern PCB designs use multi-layered boards. The data in the second row pertains to most designs.			



### 3. Calculations and Equations.

The purpose of this section is to derive the power dissipated into the load.

LVPECL output driver circuit and termination are shown in *Figure 12*.



To calculate worst case power dissipation into the load, use the following equations which assume a 50Ω load, and a termination voltage of  $V_{CC} - 2V$ .

$Pd\_H$  is power dissipation when the output drives high.

$Pd\_L$  is the power dissipation when the output drives low.

$$Pd\_H = [(V_{OH\_MAX} - (V_{CCO\_MAX} - 2V))/R_L] * (V_{CCO\_MAX} - V_{OH\_MAX})$$

$$Pd\_L = [(V_{OL\_MAX} - (V_{CCO\_MAX} - 2V))/R_L] * (V_{CCO\_MAX} - V_{OL\_MAX})$$

- For logic high,  $V_{OUT} = V_{OH\_MAX} = V_{CCO\_MAX} - 1.0V$   
Using  $V_{CCO\_MAX} = 3.465$ , this results in  $V_{OH\_MAX} = 2.465V$
- For logic low,  $V_{OUT} = V_{OL\_MAX} = V_{CCO\_MAX} - 1.7V$   
Using  $V_{CCO\_MAX} = 3.465$ , this results in  $V_{OL\_MAX} = 1.765V$

$$Pd\_H = [(2.465V - (3.465V - 2V))/50\Omega] * (3.465V - 2.465V) = 20mW$$

$$Pd\_L = [(1.765V - (3.465V - 2V))/50\Omega] * (3.465V - 1.765V) = 10.2mW$$

$$\text{Total Power Dissipation per output pair} = Pd\_H + Pd\_L = 30.2mW$$



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**ICS8432-01I**  
700MHz, CRYSTAL-TO-3.3V DIFFERENTIAL  
LVPECL FREQUENCY SYNTHESIZER

## RELIABILITY INFORMATION

TABLE 11.  $\theta_{JA}$  VS. AIR FLOW TABLE

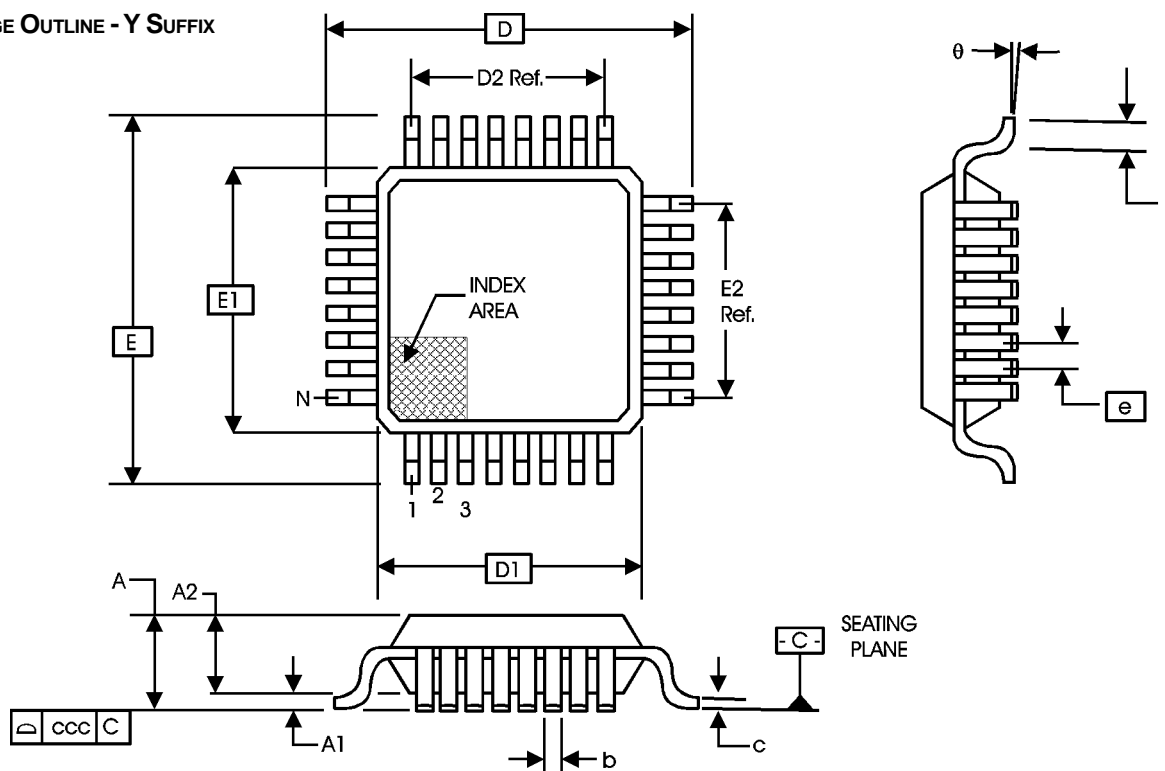
$\theta_{JA}$ by Velocity (Linear Feet per Minute)			
	0	200	500
Single-Layer PCB, JEDEC Standard Test Boards	67.8°C/W	55.9°C/W	50.1°C/W
Multi-Layer PCB, JEDEC Standard Test Boards	47.9°C/W	42.1°C/W	39.4°C/W

**NOTE:** Most modern PCB designs use multi-layered boards. The data in the second row pertains to most designs.

### TRANSISTOR COUNT

The transistor count for ICS8432-01I is: 3712

## PACKAGE OUTLINE - Y SUFFIX



### TABLE 12. PACKAGE DIMENSIONS

JEDEC VARIATION ALL DIMENSIONS IN MILLIMETERS			
SYMBOL	BBA		
	MINIMUM	NOMINAL	MAXIMUM
N	32		
A	--	--	1.60
A1	0.05	--	0.15
A2	1.35	1.40	1.45
b	0.30	0.37	0.45
c	0.09	--	0.20
D	9.00 BASIC		
D1	7.00 BASIC		
D2	5.60 Ref.		
E	9.00 BASIC		
E1	7.00 BASIC		
E2	5.60 Ref.		
e	0.80 BASIC		
L	0.45	0.60	0.75
θ	0°	--	7°
ccc	--	--	0.10

Reference Document: JEDEC Publication 95, MS-026





**TABLE 13. ORDERING INFORMATION**

Part/Order Number	Marking	Package	Count	Temperature
ICS8432CYI-01	ICS8432CYI-01	32 Lead LQFP	250 per tray	-40°C to 85°C
ICS8432CYI-01T	ICS8432CYI-01	32 Lead LQFP on Tape and Reel	1000	-40°C to 85°C

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